TLP215, 216

(TLP215)

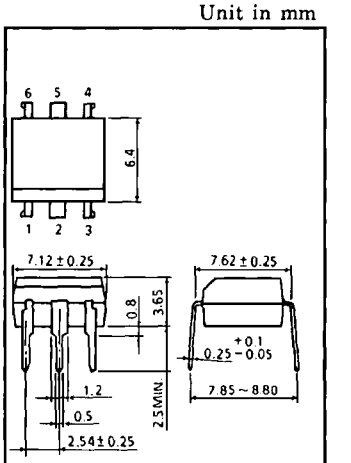
DIGITAL LOGIC INTERFACE
MICROPROCESSOR SYSTEM INTERFACE
ISOLATED BUSS DRIVER
LINE RECEIVER
GROUND LOOP ELIMINATION

The TOSHIBA TLP215 and TLP216 are logic-in and logic-out type photocouplers. Both types consist of three chips : a GaAℓAs infrared LED, LS TTL level logic IC LED driver, and photo detector which incorporates both a photo diode and TTL level logic I.C.

TLP215 : Buffer Logic Type
TLP216 : Inverter Logic Type

- Supply Voltage : V_{CC}=4.5~5.5V
- Switching Speed : t_{pHL}, t_{pLH}=5μs (MAX.)
- Guaranteed Performance Over Temperature : −25~80°C
- Isolation Voltage : 2500Vrms (MIN.)
- UL Recognized : UL1577, File No. E67349

Unit in mm

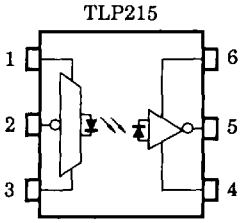


JEDEC	—
EIAJ	—
TOSHIBA	11-7A6

Weight : 0.42g

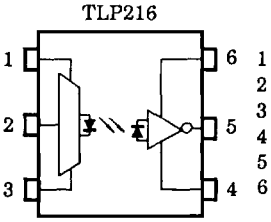
PIN CONFIGURATIONS (TOP VIEW)

TLP215



1 : V_{CCI}
2 : V_{IN} (INPUT)
3 : GND_I
4 : GND_O
5 : V_{OUT} (OUTPUT)
6 : V_{CCO}

TLP216



1 : V_{CCI}
2 : V_{IN} (INPUT)
3 : GND_I
4 : GND_O
5 : V_{OUT} (OUTPUT)
6 : V_{CCO}

TRUTH TABLE

INPUT	OUTPUT
H	H
L	L

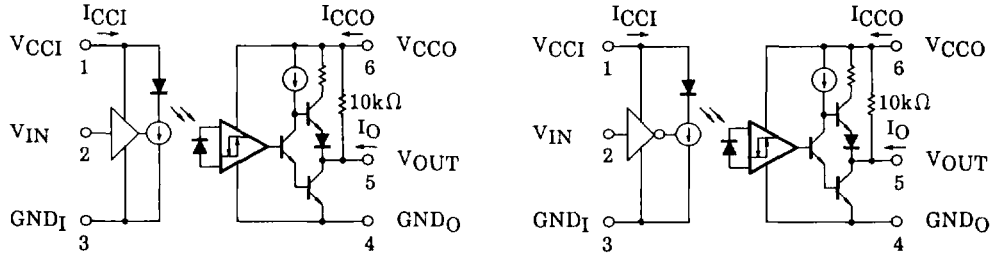
BUFFER LOGIC

INPUT	OUTPUT
H	L
L	H

INVERTER LOGIC

(TLP215)

SCHEMATIC



A 0.1μF bypass capacitor must be connected between pin 1 and 3, and between pin 4 and 6.

(TLP215)

RECOMMENDED MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	MIN.	TYP.	MAX.	UNIT
Supply Voltage	V_{CCI}, V_{CCO}	4.5	5	5.5	V
Input Voltage High	V_{IH}	2	—	V_{CC}	V
Input Voltage Low	V_{IL}	0	—	0.8	V
Output Current High	I_{OH}	—	—	−400	μA
Output Current Low	I_{OL}	—	—	8	mA
Fan Out (TTL Load)	N	—	—	4	—
Operating Temperature	T_{opr}	−25	—	85	°C

ABSOLUTE MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC			SYMBOL	RATING	UNIT
LED	Supply Voltage	(Note 1)	V_{CCI}	−0.5~7	V
	Input Voltage		V_{IN}	−0.5~7	V
DETECTOR	Supply Voltage	(Note 1)	V_{CCO}	−0.5~7	V
	Output Voltage		V_{OUT}	−0.5~7	V
	Output Current		I_{OUT}	40 / −25	mA
	Output Power Dissipation	(Note 2)	P_O	100	mW
Operating Temperature Range			T_{opr}	−40~85	°C
Storage Temperature Range			T_{stg}	−55~125	°C
Solder Temperature (10sec.)**			T_{sol}	260	°C
Isolation Voltage (AC, 1 min., R.H.≦60%, Ta=25°C)		(Note 3)	BV_S	2500	Vrms

Note 1 : Max. 1min.

Note 2 : Derate 1.8mW / °C above 70°C.

Note 3 : Pins 1, 2, 3 and 4 shorted together and pins 5, 6, 7 and 8 shorted together.

** Soldering portion of lead : up to 2mm from the body of the device.

(TLP215)

TLP215

ELECTRICAL CHARACTERISTICS (Unless otherwise specified, Ta = −25~85°C, V_{CCI}, V_{CCO} = 5V)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.*	MAX.	UNIT
Input Supply Voltage	V_{CCI}	—	4.5	5	5.5	V
Output Supply Voltage	V_{CCO}	—	4.5	5	5.5	V
Low Level Input Voltage	V_{IL}	—	—	—	0.8	V
High Level Input Voltage	V_{IH}	—	2.0	—	—	V
Low Level Output Voltage	V_{OL}	I_{OL} = 8.0mA, V_{IL} = 0.8V V_{CCO} = 4.5V	—	0.3	0.5	V
High Level Output Voltage	V_{OH}	I_{OH} = −400μA, V_{IH} = 2V V_{CCO} = 4.5V	2.7	3.6	—	V
Low Level Input Current	I_{IL}	V_{CCI} = 5.5V, V_{IL} = 0.4V	—	−0.2	−0.4	mA
High Level Input Current	I_{IH}	V_{CCI} = 5.5V, V_{IH} = 2.7V	—	—	20	μA
Input Current at Maximum Input Voltage	I_I	V_{CCI} = 5.5V, V_{IH} = 6V	—	—	0.4	mA
Input Low Level Supply Current	I_{CCLI}	V_{CCI} = 5.5V, V_{IL} = GND	—	7	10	mA
Input High Level Supply Current	I_{CCHI}	V_{CCI} = 5.5V, V_{IH} = 4.5V	—	4	10	mA
Output Low Level Supply Current	I_{CCLO}	V_{CCO} = 5.5V, V_{IH} = GND	—	4	6.0	mA
Output High Level Supply Current	I_{CCHO}	V_{CCO} = 5.5V, V_{IH} = 4.5V	—	4.5	6.0	mA
Low Level Short Circuit Output Current (Note 4)	I_{OSL}	V_{CCO} = 5.5V, V_{IL} = GND V_{OUT} = 5.5V	25	55	—	mA
High Level Short Circuit Output Current (Note 4)	I_{OSH}	V_{CCO} = 5.5V, V_{IH} = 4.5V V_{OUT} = 0V	−10	−25	—	mA
Resistance (Input-Output)	R_S	V_S = 500V, R.H. < 60% Ta = 25°C	5×10^{10}	10^{14}	—	Ω
Capacitance (Input-Output)	C_S	V_S = 0, f = 1MHz Ta = 25°C (Note 3)	—	1.0	—	pF

* All typical values at Ta = 25°C

(TLP215)

TLP215

SWITCHING CHARACTERISTICS (Unless otherwise specified, Ta = 25~85°C, $V_{CCI} = V_{CCO} = 5V$)

CHARACTERISTIC	SYMBOL	TEST CIR-CUIT	TEST CONDITION	MIN.	TYP.*	MAX.	UNIT
Propagation Delay Time (L→H) (Note 5)	t_{pLH}	1	$R_L = 2k\Omega$, $C_L = 15pF$	—	0.5	5	μs
Propagation Delay Time (H→L) (Note 5)	t_{pHL}			—	0.5	5	μs
Output Rise Time (10−90%)	t_r		$R_L = 2k\Omega$, $C_L = 15pF$ Ta = 25°C	—	35	—	ns
Output Fall Time (10−90%)	t_f			—	20	—	ns
Common Mode Transient Immunity at Logic High Output (Note 6)	C_{MH}	2	$V_{CM} = 50V$ V_{OUT} (Min.) = 2V Ta = 25°C	1000	—	—	V / μs
Common Mode Transient Immunity at Logic Low Output (Note 6)	C_{ML}		$V_{CM} = 50V$ V_{OUT} (Max.) = 0.8V Ta = 25°C	−1000	—	—	V / μs

* All typical values are at Ta = 25°C

(TLP215)

TLP216

ELECTRICAL CHARACTERISTICS (Unless otherwise specified, Ta = −25~85°C, V_{CCI}, V_{CCO} = 5V)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.*	MAX.	UNIT
Input Supply Voltage	V_{CCI}	—	4.5	5	5.5	V
Output Supply Voltage	V_{CCO}	—	4.5	5	5.5	V
Low Level Input Voltage	V_{IL}	—	—	—	0.8	V
High Level Input Voltage	V_{IH}	—	2.0	—	—	V
Low Level Output Voltage	V_{OL}	I_{OL} = 8.0mA, V_{IH} = 2V V_{CCO} = 4.5V	—	0.3	0.5	V
High Level Output Voltage	V_{OH}	I_{OH} = −400μA V_{IL} = 0.8V, V_{CCO} = 4.5V	2.7	3.6	—	V
Low Level Input Current	I_{IL}	V_{CCI} = 5.5V, V_{IL} = 0.4V	—	−0.2	−0.4	mA
High Level Input Current	I_{IH}	V_{CCI} = 5.5V, V_{IH} = 2.7V	—	—	20	μA
Input Current at Maximum Input Voltage	I_I	V_{CCI} = 5.5V, V_{IH} = 6V	—	—	0.4	mA
Input Low Level Supply Current	I_{CCLI}	V_{CCI} = 5.5V, V_{IL} = GND	—	4	10	mA
Input High Level Supply Current	I_{CCHI}	V_{CCI} = 5.5V, V_{IH} = 4.5V	—	7	10	mA
Output Low Level Supply Current	I_{CCLO}	V_{CCO} = 5.5V, V_{IH} = 4.5V	—	4	6.0	mA
Output High Level Supply Current	I_{CCHO}	V_{CCO} = 5.5V, V_{IL} = GND	—	4.5	6.0	mA
Low Level Short Circuit Output Current (Note 4)	I_{OSL}	V_{CCO} = 5.5V, V_{IH} = 4.5V V_{OUT} = 5.5V	25	55	—	mA
High Level Short Circuit Output Current (Note 4)	I_{OSH}	V_{CCO} = 5.5V, V_{IL} = GND V_{OUT} = 0V	−10	−25	—	mA
Resistance (Input-Output)	R_S	V_S = 500V, R.H. < 60% Ta = 25°C	5×10^{10}	10^{14}	—	Ω
Capacitance (Input-Output)	C_S	V_S = 0, f = 1MHz Ta = 25°C (Note 3)	—	1.0	—	pF

* All typical values are at Ta = 25°C

(TLP215)

TLP216

SWITCHING CHARACTERISTICS (Unless otherwise specified, Ta = −25~85°C, $V_{CCI} = V_{CCO} = 5V$)

CHARACTERISTIC	SYMBOL	TEST CIR-CUIT	TEST CONDITION	MIN.	TYP.*	MAX.	UNIT
Propagation Delay Time (L→H) (Note 7)	t_{pLH}	1	$R_L = 2k\Omega$, $C_L = 15pF$	—	0.5	5	μs
Propagation Delay Time (H→L) (Note 7)	t_{pHL}			—	0.5	5	μs
Output Rise Time (10−90%)	t_r		$R_L = 2k\Omega$, $C_L = 15pF$ Ta = 25°C	—	35	—	ns
Output Fall Time (10−90%)	t_f			—	20	—	ns
Common Mode Transient Immunity at Logic High Output (Note 8)	C_{MH}	2	$V_{CM} = 50V$ V_{OUT} (Min.) = 2V Ta = 25°C	−1000	—	—	V / μs
Common Mode Transient Immunity at Logic Low Output (Note 8)	C_{ML}		$V_{CM} = 50V$ V_{OUT} (Max.) = 0.8V Ta = 25°C	1000	—	—	V / μs

* All typical values are at Ta = 25°C

Note 4 : Duration of output short circuit time should not exceed 10ms

Note 5 : The t_{pLH} propagation delay is measured from the point on the trailing edge of the input pulse to the 1.3V point on the leading edge of the output pulse. The t_{pHL} propagation delay is measured from the point on the leading edge of the input pulse to the 1.3V point on the trailing edge of the output pulse.

Note 6 : C_{ML} is the maximum rate of rise of the common mode voltage that can be sustained with the output voltage in the logic low state ($V_{OUT} < 0.8V$). C_{MH} is the maximum rate of fall of the common mode voltage that can be sustained with the output voltage in the logic low state ($V_{OUT} > 2.0V$).

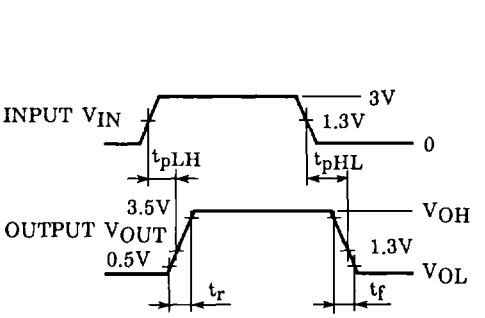
Note 7 : The t_{pLH} propagation delay is measured from the point on the trailing edge of the input pulse to the 1.3V point on the leading edge of the output pulse. The t_{pHL} propagation delay is measured from the point on the leading edge of the input pulse to the 1.3V point on the trailing edge of the output pulse.

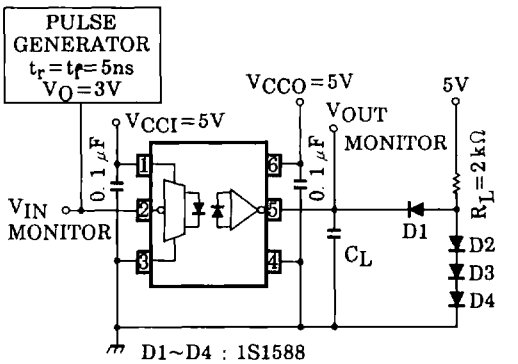
Note 8 : C_{ML} is the maximum rate of rise of the common mode voltage that can be sustained with the output voltage in the logic low state ($V_{OUT} < 0.8V$). C_{MH} is the maximum rate of fall of the common mode voltage that can be sustained with the output voltage in the logic low state ($V_{OUT} > 2.0V$).

Note 9 : A ceramic capacitor (0.1μF) should be connected from pin 1 to pin 3, and from pin 4 to pin 6 (V_{CC}-GND) to stabilize the operation of the high gain linear amplifier. Failure to provide the switching property. The total lead length between capacitor and coupler should not exceed 1cm.

(TLP215)

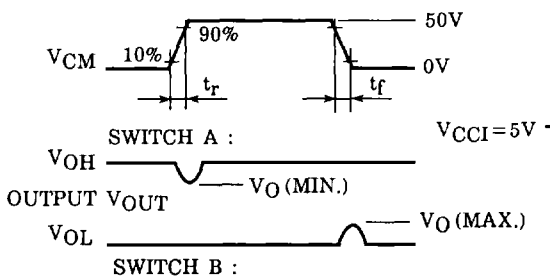
TEST CIRCUIT 1 : t_{pLH}, t_{pHL}, t_r and t_f (TLP215)

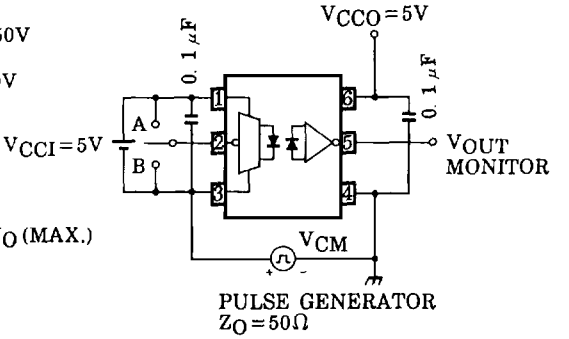




C_L is approximately 15pF which includes probe and stray wiring capacitance.

TEST CIRCUIT 2 : Common Mode Transient Immunity (TLP215)

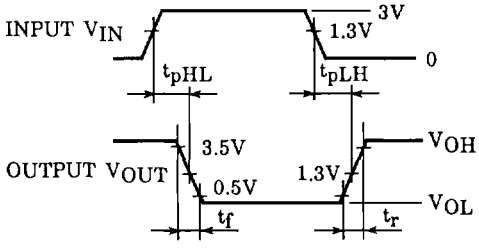


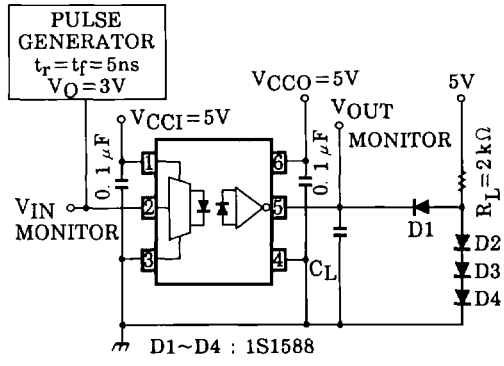


$$CM_H = \frac{45\,(V)}{t_r\,(\mu s)}\ ,\ CM_L = \frac{45\,(V)}{t_f\,(\mu s)}$$

(TLP215)

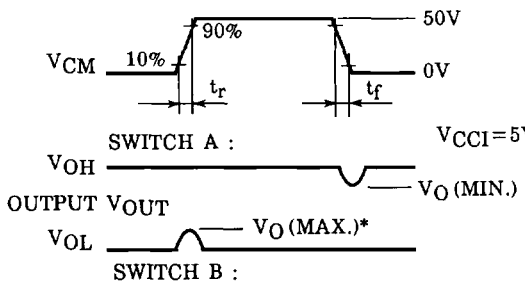
TEST CIRCUIT 3 : t_{pLH}, t_{pHL}, t_r and t_f (TLP216)

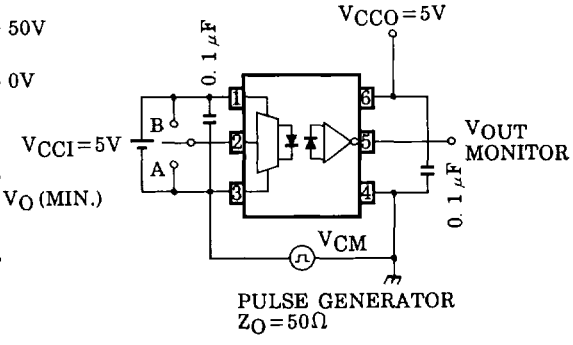




C_L is approximately 15pF which includes probe and stray wiring capacitance.

TEST CIRCUIT 4 : Common Mode Transient Immunity (TLP216)





$$CM_H = \frac{45\,(V)}{t_f\,(\mu s)}\ ,\ CM_L = \frac{45\,(V)}{t_r\,(\mu s)}$$